



<b>Search Notes</b>  	Application/Control No.  09944317	Applicant(s)/Patent Under Reexamination  PARAGIOS ET AL.
	Examiner Lavin, Christopher L	Art Unit 2624

Notes	Date	Examiner
Updated East Search	08/09/2006	CLL
Updated IEEE Search	08/08/2006	CLL

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<b><i>Interference Searched</i></b>  	Application/Control No.  09944317	Applicant(s)/Patent Under Reexamination  PARAGIOS ET AL.
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